

## 100V,320A N-CHANNEL POWER MOSFET

### GENERAL DESCRIPTION

The SGL101R5T uses advanced SGT technology and design to provide excellent  $R_{DS(on)}$  with low gate charge.

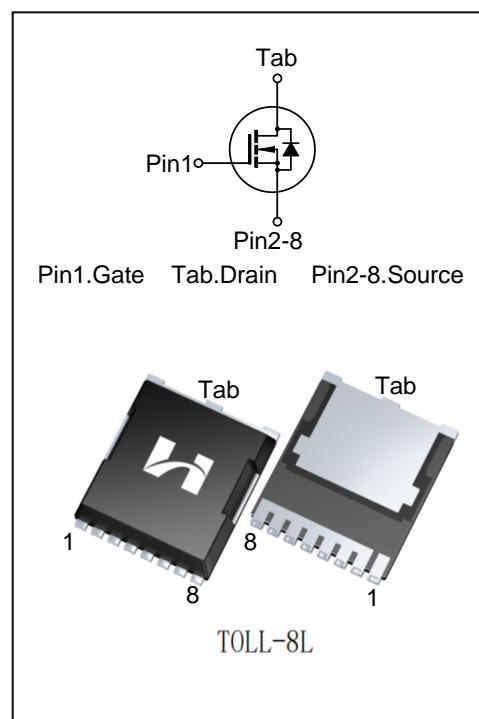
It can be used in a wide variety applications.

### Features

- ◆  $V_{DS}=100V, I_D=320A$
- ◆  $R_{DS(on)}$   
TYP:  $1.1m\Omega @ V_{GS}=10V$

### Applications

- ◆ Power factor correction (PFC)
- ◆ Switched mode power supplies (SMPS)
- ◆ Uninterruptible power supply (UPS)
- ◆ LED lighting power



### ORDERING INFORMATION

Part No.	Package	Marking	Material	Packing
SGL101R5T	TOLL-8L	SGL101R5T	Pb Free	Reel

**ABSOLUTE MAXIMUM RATINGS (T<sub>J</sub>=25°C unless otherwise noted)**

Characteristics		Symbol	Ratings			Unit
Drain-Source Voltage		V <sub>DS</sub>	100			V
Gate-Source Voltage		V <sub>GS</sub>	±20			V
Drain Current	T <sub>C</sub> = 25°C	I <sub>D</sub>	320			A
	T <sub>C</sub> = 100°C		210			
Drain Current Pulsed (Note 1)		I <sub>DM</sub>	1280			A
Power Dissipation(T <sub>C</sub> =25°C) -Derate above 25°C		P <sub>D</sub>	321			W
			2.14			W/°C
Single Pulsed Avalanche Energy (Note 2)	E <sub>AS</sub>		3200			mJ
Operation Junction Temperature Range	T <sub>J</sub>		-55~+150			°C
Storage Temperature Range	T <sub>stg</sub>		-55~+150			°C
Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	TL		300			°C

**THERMAL CHARACTERISTICS**

Characteristics	Symbol	Ratings			Unit
Thermal Resistance, Junction-to-Case	R <sub>θJC</sub>	0.39			°C/W
Thermal Resistance, Junction-to-Ambient	R <sub>θJA</sub>	45			°C/W

**ELECTRICAL CHARACTERISTICS**

Characteristics	Symbol	Test conditions	Min.	Typ.	Max.	Unit
<b>Off Characteristics</b>						
Drain -Source Breakdown Voltage	B <sub>VDSS</sub>	V <sub>GS</sub> =0V, I <sub>D</sub> =250μA	100	--	--	V
Drain-Source Leakage Current	I <sub>bss</sub>	V <sub>DS</sub> =100V, V <sub>GS</sub> =0V	--	--	100	nA
Gate-Source Leakage Current	I <sub>gss</sub>	V <sub>GS</sub> =20V, V <sub>DS</sub> =0V	--	--	100	nA
Gate-Source Leakage Current	I <sub>gss</sub>	V <sub>GS</sub> =-20V, V <sub>DS</sub> =0V	--	--	-100	nA
<b>On Characteristics</b>						
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub> =250μA	2.2	--	3.8	V
Static Drain- Source On State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =150A	--	1.1	1.5	mΩ
		V <sub>GS</sub> =6.0V, I <sub>D</sub> =75A	--	1.3	1.7	mΩ
<b>Dynamic Characteristics</b>						
Gate Resistance	R <sub>g</sub>	V <sub>GS</sub> =0V; f=1.0MHZ	--	2.8	--	Ω
Input Capacitance	C <sub>iss</sub>	V <sub>DS</sub> =50V V <sub>GS</sub> =0V f=1.0MHZ	--	17694	--	pF
Output Capacitance	C <sub>oss</sub>		--	2681	--	
Reverse Transfer Capacitance	C <sub>rss</sub>		--	66	--	
<b>Switching Characteristics</b>						
Turn-on Delay Time	t <sub>d(on)</sub>	V <sub>DD</sub> =50V V <sub>GS</sub> =10V R <sub>G</sub> =1.8Ω I <sub>D</sub> =100A	--	47	--	ns
Turn-on Rise Time	t <sub>r</sub>		--	85	--	
Turn-off Delay Time	t <sub>d(off)</sub>		--	139	--	
Turn-off Fall Time	t <sub>f</sub>		--	78	--	
Total Gate Charge	Q <sub>g</sub>	V <sub>DD</sub> =50V, I <sub>D</sub> =100A V <sub>GS</sub> =10V	--	239	--	nc
Gate-Source Charge	Q <sub>gs</sub>		--	85	--	
Gate-Drain Charge	Q <sub>gd</sub>		--	40	--	

## SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS

Characteristics	Symbol	Test conditions	Min.	Typ.	Max.	Unit
Continuous Source Current	$I_S$	Integral Reverse P-N Junction Diode in the MOSFET	--	--	320	A
Pulsed Source Current	$I_{SM}$		--	--	1280	
Diode Forward Voltage	$V_{SD}$	$I_S=100A, V_{GS}=0V$	--		1.4	V
Reverse Recovery Time	$T_{rr}$	$I_S=100A, V_R=80V,$ $dI/dt=100A/\mu s$	--	111	--	ns
Reverse Recovery Charge	$Q_{rr}$		--	299	--	$\mu C$

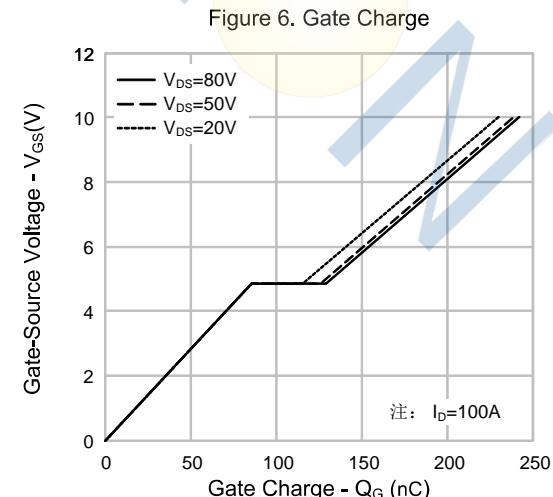
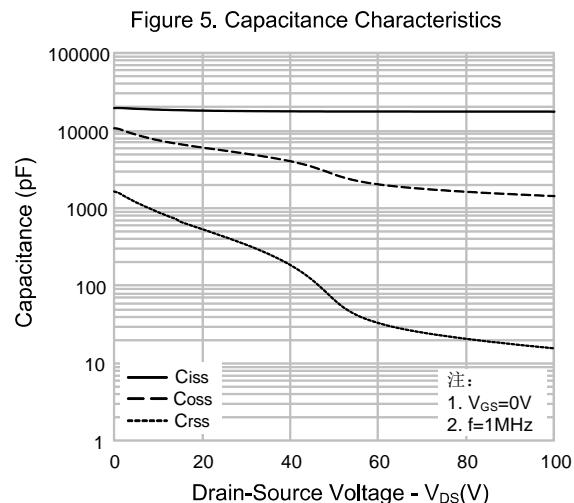
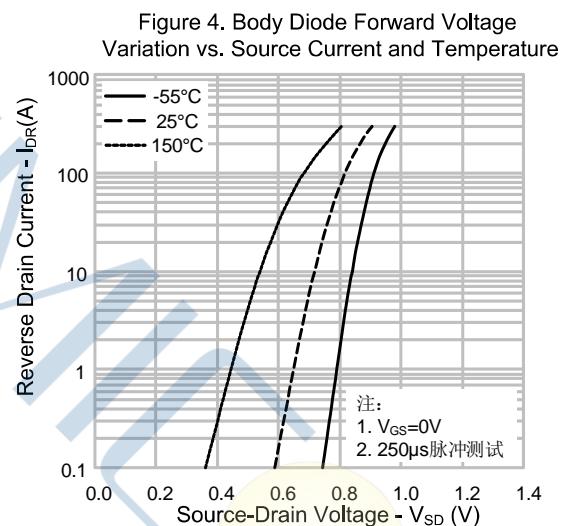
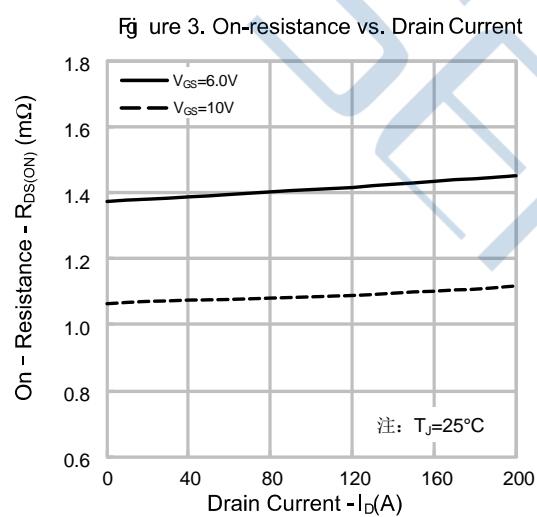
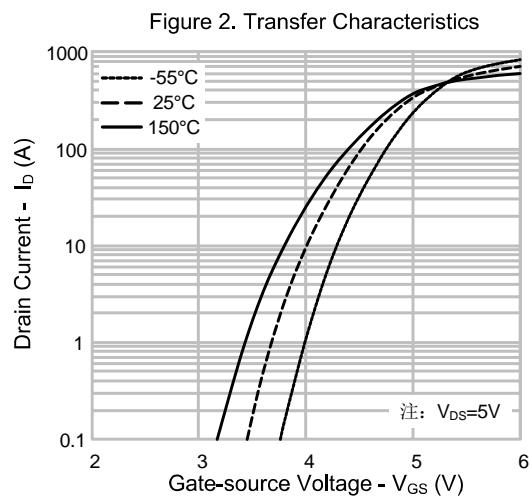
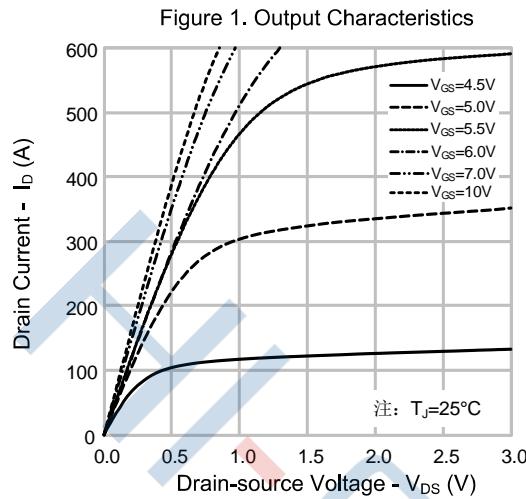
1. Pulse width limited by maximum junction temperature

2.  $L=1.0mH, V_{DD}=80V, V_G=10V, R_G=25\Omega$ , starting  $T_J=25^\circ C$

3. Pulse Test: Pulse width  $\leq 300\mu s$ , Duty cycles  $\leq 2\%$

4. Essentially independent of operating temperature

## Typical Performance Characteristics



## Typical Performance Characteristics

Figure 7. Breakdown Voltage vs. Temperature Characteristics

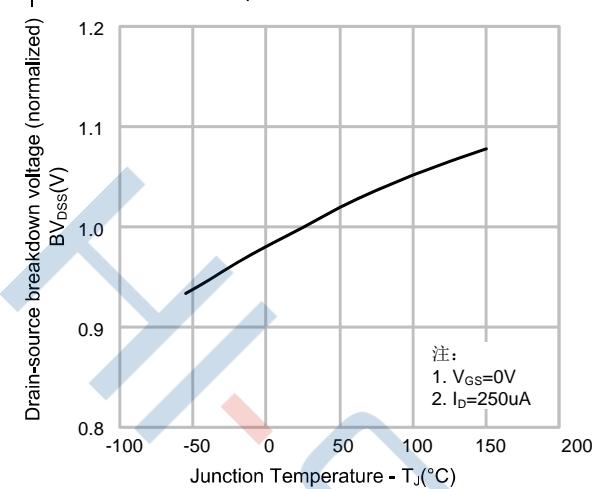


Figure 8. On-resistance vs. Temperature Characteristics

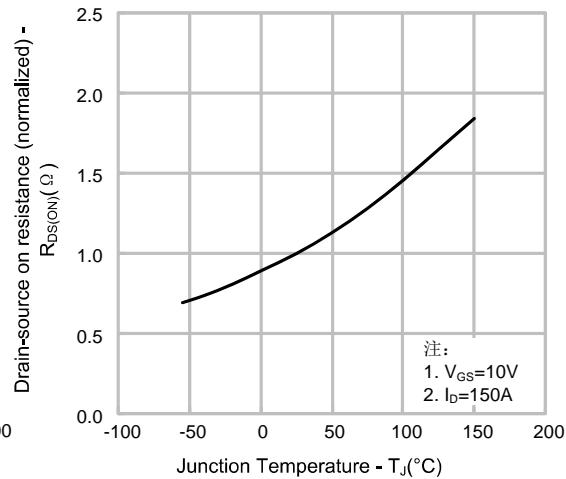
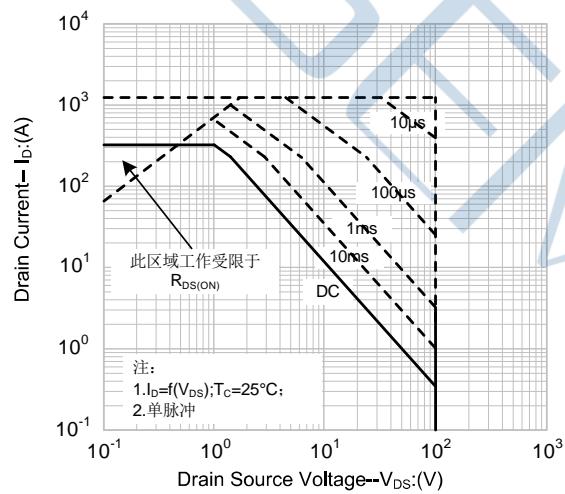
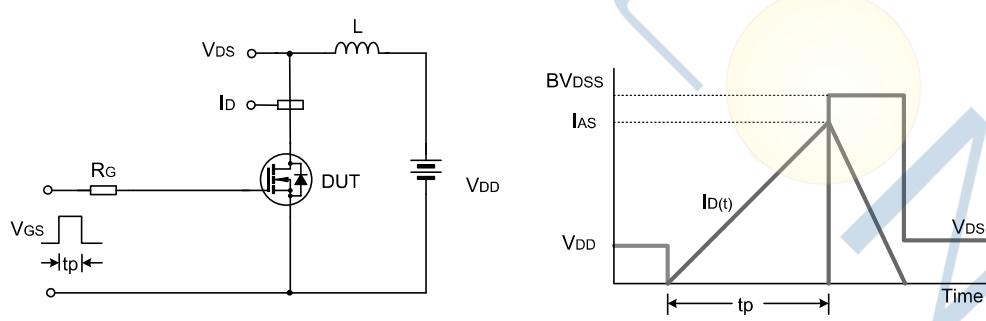
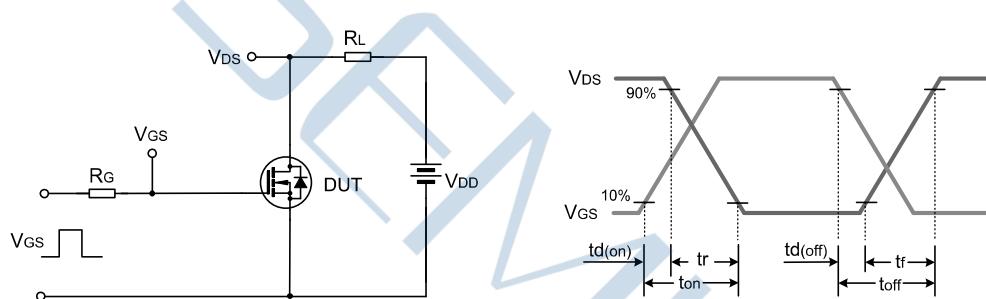
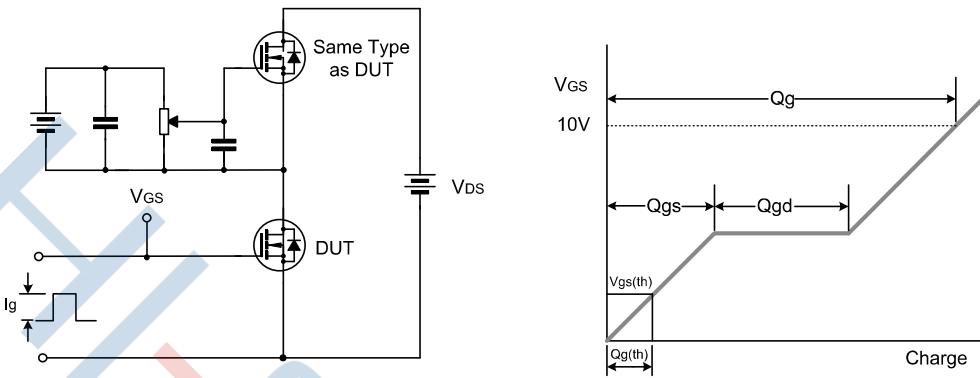
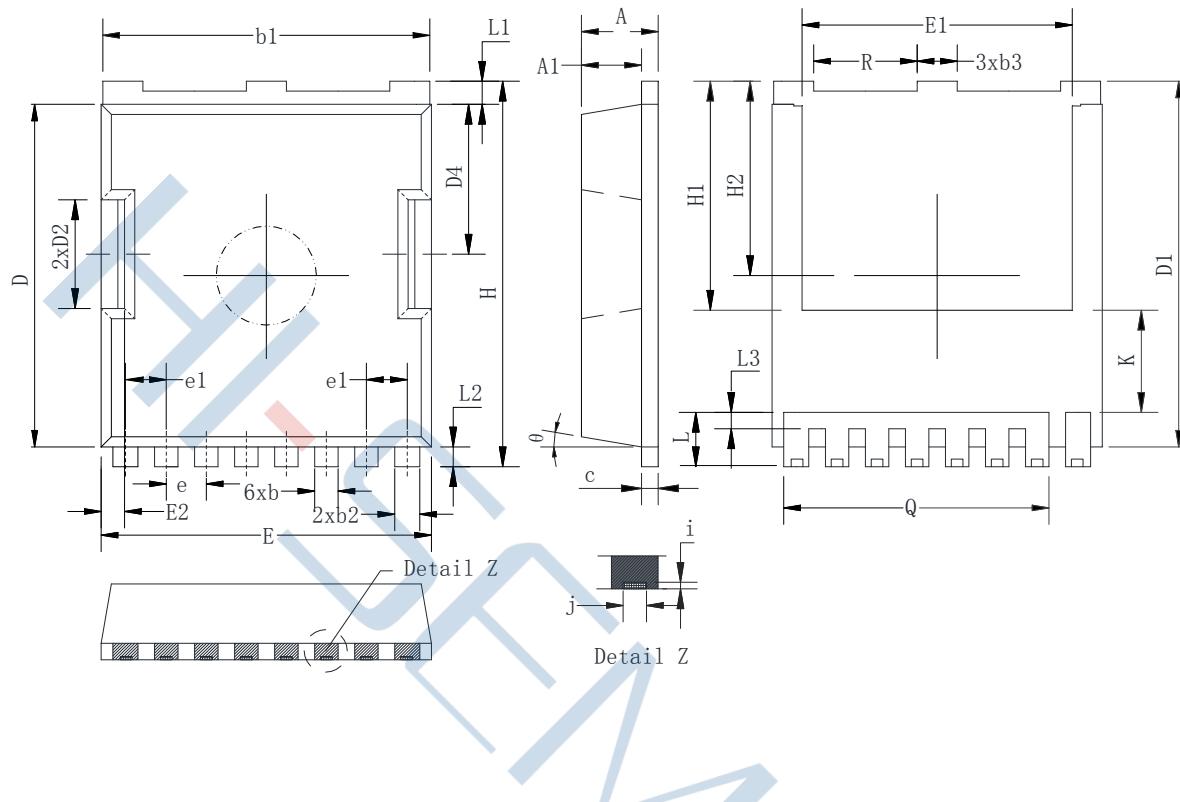


Figure 9. Max. Safe Operating



**Test Circuit**

## Package Dimensions of TOLL-8L



Symbol	Min	Typ	Max	Symbol	Min	Typ	Max
A	2.25	2.30	2.35	E2	0.65	0.70	0.75
A1	1.75	1.80	1.85	H	11.60	11.70	11.80
b	0.65	0.70	0.75	H1		6.95 BSC	
b1	9.75	9.80	9.85	H2		5.90 BSC	
b2	0.70	0.75	0.80	i		0.10 REF	
b3	1.15	1.20	1.25	j		0.35 REF	
c	0.45	0.50	0.55	K		3.10 REF	
D	10.35	10.40	10.45	L	1.55	1.65	1.75
D1	11.00	11.10	11.20	L1	0.65	0.70	0.75
D2	3.25	3.30	3.35	L2	0.50	0.60	0.70
D4	4.50	4.55	4.60	L3	0.40	0.50	0.60
e		1.20 BSC		Q		7.95 REF	
e1		1.225 BSC		R	3.05	3.10	3.15
E	9.85	9.90	9.95	$\theta$		10°REF	
E1	8.00	8.10	8.20				

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